Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,795	KAWAMAE ET AL.
Examiner	Art Unit
LaTanya Bibbins	2627

SEARCHED					
Class	Subclass	Date	Examiner		
369	47.3	9/6/2006	LB		
369	47.31	9/6/2006	LB		
369	59.25	9/11/2006	LB		
369	30.11	9/12/2006	LB		
369	53.24	9/18/2002	LB		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Databases Searched: USPAT, USPGPub, USOCR, EPO, JPO, DERWENT, IBM_TDB (see search history attached)	9/6/2006	LB		
NPL searches including Google, IEEE Xplore, Inspec, and Optics Information Database (search terms are the same as EAST	9/6/2006	LB		
Inventor Name Search	9/6/2006	LB		
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